Search Notes

Application/Control No.	No. Applicant(s)/Patent under Reexamination	
10/805,365	TANAKA ET AL.	
Examiner	Art Unit	
VanThu Nguyen	2824	

SEARCHED					
Class	Subclass	Date	Examiner		
365	185.01 185.02 o 185.05	11/16/2005	VTN		
	185.18 x				
	189.01				
	189.09 x				
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST Search (see print out history)	11/16/2005	VTN		